

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/691,440	ATKEY ET AL.
Examiner	Art Unit	
Trinh T. Nguyen	3644	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
PGPUB	text	10/2/2005	TTN
search	see		
print	out		